Search Notes

Application/Control No.	

Applicant(s)/Patent under Reexamination

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Examiner
Leon Flores

KUBOTA, SHINPEI

Art Unit

2611

SEARCHED					
Class	Subclass	Date	Examiner		
375	316, 345	12/12/2006	LF		
455	234.1	12/12/2006	LF		
455	232.1	12/12/2006	LF		
455	239.1 .	12/12/2006	LF		
455	240.1	12/12/2006	LF		
455	245.1	12/12/2006	LF		
455	247.1	12/12/2006	LF		
455	250.1	12/12/2006	LF		
330	129, 254	12/12/2006	LF		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
	1				

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted with SPE Vu Le in regards to the patentability of claim 1.	.12/12/2006	, LF
Consulted with Juan Torres in regards to the patentability of claim 1.	12/12/2006	LF
Checked for double patenting	12/12/2006	LF
Searched in IEEE using author name.	12/12/2006	LF
Consulted with Chieh Fan	7/18/2007	LF